## 10-Bit, 125/60MSPS, High Speed D/A Converter

The HI5760 is a 10 -bit, 125 MSPS , high speed, low power, D/A converter which is implemented in an advanced CMOS process. Operating from a single +3 V to +5 V supply, the converter provides 20 mA of full scale output current and includes edge-triggered CMOS input data latches. Low glitch energy and excellent frequency domain performance are achieved using a segmented current source architecture. For an equivalent performance dual version, see the HI5728.

This device complements the HI5X60 family of high speed converters offered by Intersil, which includes 8, 10, 12, and 14-bit devices.

## Ordering Information

| PART <br> NUMBER | TEMP. <br> RANGE ( ${ }^{\circ}$ C $)$ | PACKAGE | PKG. <br> NO. | CLOCK <br> SPEED |
| :--- | :---: | :--- | :--- | :--- |
| HI5760BIB | -40 to 85 | 28 Ld SOIC | M28.3 | 125 MHz |
| HI5760BIBZ <br> (See Note) | -40 to 85 | 28 Ld SOIC <br> (Pb-free) | M28.3 | 125 MHz |
| HI5760IA | -40 to 85 | 28 Ld TSSOP | M28.173 | 125 MHz |
| HI5760IAZ <br> (See Note) | -40 to 85 | 28 Ld TSSOP <br> (Pb-free) | M 28.173 | 125 MHz |
| HI5760/6IB | -40 to 85 | 28 Ld SOIC | M 28.3 | 60 MHz |
| HI5760/6IBZ <br> (See Note) | -40 to 85 | 28 Ld SOIC <br> (Pb-free) | M 28.3 | 60 MHz |
| HI5760EVAL1 | 25 | Evaluation Platform | 125 MHz |  |

* Add "-T" suffix for tape and reel.

NOTE: Intersil Pb-free products employ special Pb-free material sets; molding compounds/die attach materials and 100\% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb -free soldering operations. Intersil Pb -free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

## Features

- Throughput Rate . . . . . . . . . . . . . . . . . . . . . . . . 125MSPS
- Low Power . . . . . . . . . . . . . . . 165mW at 5V, 27 mW at 3V
- Power Down Mode. . . . . . . . . . 23mW at 5V, 10 mW at 3 V
- Integral Linearity Error $\pm 1$ LSB
- Adjustable Full Scale Output Current. . . . . $2 m A$ to 20 mA
- SFDR to Nyquist at 5MHz Output . . . . . . . . . . . . . . 68dBc
- Internal 1.2V Temperature Compensated Bandgap Voltage Reference
- Single Power Supply from +5 V to +3 V
- CMOS Compatible Inputs
- Excellent Spurious Free Dynamic Range
- Pb-Free Available (RoHS Compliant)


## Applications

- Cable Modems
- Set Top Boxes
- Wireless Communications
- Direct Digital Frequency Synthesis
- Signal Reconstruction
- Test Instrumentation
- High Resolution Imaging Systems
- Arbitrary Waveform Generators


## Pinout

H15760 (SOIC, TSSOP) TOP VIEW

| D9 (MSB) 1 | V | 28 CLK |
| :---: | :---: | :---: |
| D8 2 |  | 27 DV D |
| D7 3 |  | 26 dCOM |
| D6 4 |  | 25 NC |
| D5 5 |  | 24 AV DD |
| D4 6 |  | 23 NC |
| D3 7 |  | 22 IOUTA |
| D2 8 |  | 21 IOUTB |
| D1 9 |  | 20 АСОм |
| D0 (LSB) 10 |  | 19 COMP1 |
| NC 11 |  | 18 FSADJ |
| NC 12 |  | 17 REFIO |
| NC 13 |  | 16 REFLO |
| NC 14 |  | 15 SLEEP |

## Typical Applications Circuit



Functional Block Diagram


2

## Absolute Maximum Ratings

Digital Supply Voltage DV ${ }_{\text {DD }}$ to DCOM . . . . . . . . . . . . . . . . . +5.5 V
Analog Supply Voltage AV $\mathrm{DD}_{\text {D }}$ to ACOM . . . . . . . . . . . . . . . . . +5.5 V
Grounds, ACOM TO DCOM ..................... . 0.3 V To +0.3 V
Digital Input Voltages (D9-D0, CLK, SLEEP) . . . . . . DV $\mathrm{DD}_{\mathrm{DD}}+0.3 \mathrm{~V}$
Internal Reference Output Current . . . . . . . . . . . . . . . . . . . . . . . $\pm 50 \mu \mathrm{~A}$
Reference Input Voltage Range. . . . . . . . . . . . . . . . . . . AV $\mathrm{AD}+0.3 \mathrm{~V}$
Analog Output Current (IOUT) . . . . . . . . . . . . . . . . . . . . . . . . . . 24mA

## Operating Conditions

Temperature Range. $\qquad$ $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$

## Thermal Information

| Thermal Resistance (Typical, Note 1) | $\theta_{\mathrm{JA}}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right)$ |
| :---: | :---: |
| SOIC Package | 75 |
| TSSOP Package | 135 |
| Maximum Junction Temperature HI5760 | $.150^{\circ} \mathrm{C}$ |
| Maximum Storage Temperature Range | ${ }^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ |
| Maximum Lead Temperature (Soldering 10s) (SOIC - Lead Tips Only) | $300^{\circ} \mathrm{C}$ |

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.
NOTE:

1. $\theta_{\mathrm{JA}}$ is measured with the component mounted on an evaluation PC board in free air.

Electrical Specifications $\quad A V_{D D}=D V_{D D}=+5 \mathrm{~V}, \mathrm{~V}_{R E F}=$ Internal 1.2 V , IOUTFS $=20 \mathrm{~mA}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ for All Typical Values

| PARAMETER | TEST CONDITIONS | $\begin{gathered} \mathrm{H} 15760 \\ \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C} \text { TO } 85^{\circ} \mathrm{C} \end{gathered}$ |  |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYP | MAX |  |
| SYSTEM PERFORMANCE |  |  |  |  |  |
| Resolution |  | 10 | - | - | Bits |
| Integral Linearity Error, INL | "Best Fit" Straight Line (Note 7) | -1 | $\pm 0.5$ | +1 | LSB |
| Differential Linearity Error, DNL | (Note 7) | -0.5 | $\pm 0.25$ | +0.5 | LSB |
| Offset Error, IOS | (Note 7) | -0.025 |  | +0.025 | \% FSR |
| Offset Drift Coefficient | (Note 7) | - | 0.1 | - | $\begin{gathered} \mathrm{ppm} \\ \mathrm{FSR} /{ }^{\circ} \mathrm{C} \end{gathered}$ |
| Full Scale Gain Error, FSE | With External Reference (Notes 2, 7) | -10 | $\pm 2$ | +10 | \% FSR |
|  | With Internal Reference (Notes 2, 7) | -10 | $\pm 1$ | +10 | \% FSR |
| Full Scale Gain Drift | With External Reference (Note 7) | - | $\pm 50$ | - | $\begin{gathered} \mathrm{ppm} \\ \mathrm{FSR} /{ }^{\circ} \mathrm{C} \end{gathered}$ |
|  | With Internal Reference (Note 7) | - | $\pm 100$ | - | $\begin{gathered} \mathrm{ppm} \\ \mathrm{FSR} /{ }^{\circ} \mathrm{C} \end{gathered}$ |
| Full Scale Output Current, $\mathrm{I}_{\text {FS }}$ |  | 2 | - | 20 | mA |
| Output Voltage Compliance Range | (Note 3) | -0.3 | - | 1.25 | V |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |
| Maximum Clock Rate, $\mathrm{f}_{\text {CLK }}$ | (Note 3) | 125 | - | - | MHz |
| Output Settling Time, (tSETT) | 0.2\% ( $\pm 1 \mathrm{LSB}$, equivalent to 9 Bits) (Note 7) | - | 20 | - | ns |
|  | $0.1 \%$ ( $\pm 1 / 2$ LSB, equivalent to 10 Bits) (Note 7) | - | 35 | - | ns |
| Singlet Glitch Area (Peak Glitch) | $\mathrm{R}_{\mathrm{L}}=25 \Omega$ ( Note 7) | - | 5 | - | $\mathrm{pV} \cdot \mathrm{s}$ |
| Output Rise Time | Full Scale Step | - | 1.0 | - | ns |
| Output Fall Time | Full Scale Step | - | 1.5 | - | ns |
| Output Capacitance |  | - | 10 | - | pF |
| Output Noise | IOUTFS $=20 \mathrm{~mA}$ | - | 50 | - | $\mathrm{pA} / \sqrt{\mathrm{Hz}}$ |
|  | IOUTFS = 2mA | - | 30 | - | $\mathrm{pA} / \sqrt{\mathrm{Hz}}$ |


| Electrical Specifications $A V_{D D}=D V_{D D}=+5 \mathrm{~V}, \mathrm{~V}_{\mathrm{REF}}=$ Internal 1.2 V , IOUTFS $=20 \mathrm{~mA}, \mathrm{~T}_{\text {A }}=25^{\circ} \mathrm{C}$ for All Typical Values (Continued) |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER | TEST CONDITIONS | $\begin{gathered} \mathrm{H} 15760 \\ \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C} \mathrm{TO} 85^{\circ} \mathrm{C} \end{gathered}$ |  |  | UNITS |
|  |  | MIN | TYP | MAX |  |
| AC CHARACTERISTICS - HI5760BIB, HI5760IA - 125MHz |  |  |  |  |  |
| Spurious Free Dynamic Range, SFDR Within a Window | $\mathrm{f}_{\text {CLK }}=125 \mathrm{MSPS}, \mathrm{fOUT}=32.9 \mathrm{MHz}, 10 \mathrm{MHz}$ Span (Notes 4, 7) | - | 75 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=100 \mathrm{MSPS}, \mathrm{f}$ OUT $=5.04 \mathrm{MHz}, 4 \mathrm{MHz}$ Span (Notes 4, 7) | - | 76 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=60 \mathrm{MSPS}$, fout $=10.1 \mathrm{MHz}, 10 \mathrm{MHz}$ Span (Notes 4, 7) | - | 75 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}$, fout $=5.02 \mathrm{MHz}$, 2MHz Span (Notes 4, 7) | - | 76 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}, \mathrm{fOUT}=1.00 \mathrm{MHz}$, 2MHz Span (Notes 4, 7) | - | 78 | - | dBc |
| Total Harmonic Distortion (THD) to Nyquist | $\mathrm{f}^{\text {CLK }}=100 \mathrm{MSPS}, \mathrm{f}$ OUT $=2.00 \mathrm{MHz}($ Notes 4, 7) | - | 71 | - | dBc |
|  | $\mathrm{f} C$ LK $=50 \mathrm{MSPS}, \mathrm{fOUT}=2.00 \mathrm{MHz}($ Notes 4, 7) | - | 71 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}, \mathrm{fOUT}=1.00 \mathrm{MHz}($ Notes 4, 7) | - | 76 | - | dBc |
| Spurious Free Dynamic Range, SFDR to Nyquist | $\mathrm{f}_{\mathrm{CLK}}=125 \mathrm{MSPS}, \mathrm{f}$ OUT $=32.9 \mathrm{MHz}, 62.5 \mathrm{MHz}$ Span (Notes 4, 7) | - | 54 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=125 \mathrm{MSPS}$, $\mathrm{f}_{\text {OUT }}=10.1 \mathrm{MHz}, 62.5 \mathrm{MHz}$ Span (Notes 4, 7) | - | 64 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=100 \mathrm{MSPS}, \mathrm{fOUT}=40.4 \mathrm{MHz}, 50 \mathrm{MHz}$ Span ( Notes 4, 7) | - | 52 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=100 \mathrm{MSPS}, \mathrm{f}$ OUT $=20.2 \mathrm{MHz}, 50 \mathrm{MHz}$ Span ( Notes 4, 7) | - | 60 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=100 \mathrm{MSPS}, \mathrm{f}$ OUT $=5.04 \mathrm{MHz}, 50 \mathrm{MHz}$ Span (Notes 4, 7) | - | 68 | - | dBc |
|  | $\mathrm{f}^{\text {CLK }}=100 \mathrm{MSPS}, \mathrm{f}$ OUT $=2.51 \mathrm{MHz}, 50 \mathrm{MHz}$ Span ( Notes 4, 7) | - | 74 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=60 \mathrm{MSPS}$, fout $=10.1 \mathrm{MHz}, 30 \mathrm{MHz}$ Span (Notes 4, 7) | - | 63 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}$, fout $=20.2 \mathrm{MHz}, 25 \mathrm{MHz}$ Span (Notes 4, 7) | - | 55 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}$, fout $=5.02 \mathrm{MHz}, 25 \mathrm{MHz}$ Span (Notes 4, 7) | - | 68 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}$, f OUT $=2.51 \mathrm{MHz}, 25 \mathrm{MHz}$ Span ( Notes 4, 7) | - | 73 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}$, fout $=1.00 \mathrm{MHz}, 25 \mathrm{MHz}$ Span (Notes 4, 7) | - | 73 | - | dBc |
| AC CHARACTERISTICS - HI5760/6IB, HI5760/6IA - 60MHz |  |  |  |  |  |
| Spurious Free Dynamic Range, SFDR Within a Window | $\mathrm{f}_{\text {CLK }}=60 \mathrm{MSPS}$, fout $=10.1 \mathrm{MHz}, 10 \mathrm{MHz}$ Span (Notes 4, 7) | - | 75 | - | dBc |
|  | $\mathrm{f}^{\text {CLK }}=50 \mathrm{MSPS}, \mathrm{fOUT}=5.02 \mathrm{MHz}, 2 \mathrm{MHz} \mathrm{Span} \mathrm{(Notes} \mathrm{4}, \mathrm{7)}$ | - | 76 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}, \mathrm{f}$ OUT $=1.00 \mathrm{MHz}, 2 \mathrm{MHz}$ Span (Notes 4, 7) | - | 78 | - | dBc |
| Total Harmonic Distortion (THD) to Nyquist | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}, \mathrm{fOUT}=2.00 \mathrm{MHz}($ Notes 4, 7) | - | 71 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}, \mathrm{fOUT}=1.00 \mathrm{MHz}($ Notes 4, 7) | - | 76 | - | dBc |
| Spurious Free Dynamic Range, SFDR to Nyquist | $\mathrm{f}^{\text {CLK }}=60 \mathrm{MSPS}$, fout $=20.2 \mathrm{MHz}, 30 \mathrm{MHz}$ Span (Notes 4, 7) | - | 56 | - | dBc |
|  | $\mathrm{f}^{\text {CLK }}=60 \mathrm{MSPS}$, f OUT $=10.1 \mathrm{MHz}, 30 \mathrm{MHz}$ Span (Notes 4, 7) | - | 63 | - | dBc |
|  | $\mathrm{f}^{\text {CLK }}=50 \mathrm{MSPS}$, fout $=20.2 \mathrm{MHz}, 25 \mathrm{MHz}$ Span (Notes 4, 7) | - | 55 | - | dBc |
|  | $\mathrm{f}^{\text {CLK }}=50 \mathrm{MSPS}$, fout $=5.02 \mathrm{MHz}, 25 \mathrm{MHz}$ Span (Notes 4, 7) | - | 68 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}$, f OUT $=2.51 \mathrm{MHz}, 25 \mathrm{MHz}$ Span (Notes 4, 7) | - | 73 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=50 \mathrm{MSPS}$, $\mathrm{fOUT}=1.00 \mathrm{MHz}, 25 \mathrm{MHz}$ Span (Notes 4, 7) | - | 73 | - | dBc |
|  | $\mathrm{f}_{\text {CLK }}=25 \mathrm{MSPS}$, f Out $=5.02 \mathrm{MHz}, 25 \mathrm{MHz}$ Span (Notes 4, 7) | - | 71 | - | dBc |
| VOLTAGE REFERENCE |  |  |  |  |  |
| Internal Reference Voltage, $\mathrm{V}_{\text {FSADJ }}$ | Pin 18 Voltage with Internal Reference | 1.04 | 1.16 | 1.28 | V |
| Internal Reference Voltage Drift |  | - | $\pm 60$ | - | ppm $/{ }^{\circ} \mathrm{C}$ |
| Internal Reference Output Current Sink/Source Capability |  | - | 0.1 | - | $\mu \mathrm{A}$ |
| Reference Input Impedance |  | - | 1 | - | $\mathrm{M} \Omega$ |
| Reference Input Multiplying Bandwidth | (Note 7) | - | 1.4 | - | MHz |


| Electrical Specifications AV | $=D \mathrm{~V}_{\mathrm{DD}}=+5 \mathrm{~V}, \mathrm{~V}_{\text {REF }}=$ Internal 1.2 V , IOU | for | pica | s | ntinued) |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\begin{aligned} & \mathrm{H} 15760 \\ & 10^{\circ} \mathrm{C} \mathrm{~T} \end{aligned}$ |  |  |
| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNITS |
| DIGITAL INPUTS D9-D0, CLK |  |  |  |  |  |
| Input Logic High Voltage with 5 V Supply, $\mathrm{V}_{\mathrm{IH}}$ | (Note 3) | 3.5 | 5 | - | V |
| Input Logic High Voltage with 3V Supply, $\mathrm{V}_{\mathrm{IH}}$ | (Note 3) | 2.1 | 3 | - | V |
| Input Logic Low Voltage with 5V Supply, VIL | (Note 3) | - | 0 | 1.3 | V |
| Input Logic Low Voltage with 3V Supply, VIL | (Note 3) | - | 0 | 0.9 | V |
| Input Logic Current, $\mathrm{I}_{\mathrm{IH}}$ |  | -10 | - | +10 | $\mu \mathrm{A}$ |
| Input Logic Current, $\mathrm{I}_{\text {IL }}$ |  | -10 | - | +10 | $\mu \mathrm{A}$ |
| Digital Input Capacitance, $\mathrm{C}_{\text {IN }}$ |  | - | 5 | - | pF |
| TIMING CHARACTERISTICS |  |  |  |  |  |
| Data Setup Time, tsu | See Figure 41 (Note 3) | 3 | - | - | ns |
| Data Hold Time, thLD | See Figure 41 (Note 3) | 3 | - | - | ns |
| Propagation Delay Time, trd | See Figure 41 | - | 1 | - | ns |
| CLK Pulse Width, tPW1, tPW2 | See Figure 41 (Note 3) | 4 | - | - | ns |
| POWER SUPPLY CHARACTERISTICS |  |  |  |  |  |
| AV ${ }_{\text {DD }}$ Power Supply | (Note 8) | 2.7 | 5.0 | 5.5 | V |
| DV ${ }_{\text {DD }}$ Power Supply | (Note 8) | 2.7 | 5.0 | 5.5 | V |
| Analog Supply Current ( ${ }_{\text {AVDD }}$ ) | ( 5 V or 3 V, IOUTFS $=20 \mathrm{~mA}$ ) | - | 23 | 30 | mA |
|  | ( 5 V or 3 V, IOUTFS $=2 \mathrm{~mA}$ ) | - | 4 | - | mA |
| Digital Supply Current (ldvDD) | (5V, IOUTFS = Don't Care) (Note 5) | - | 3 | 5 | mA |
|  | (3V, IOUTFS = Don't Care) (Note 5) | - | 1.5 | - | mA |
| Supply Current (IAVDD) Sleep Mode | (5V or 3V, IOUTFS = Don't Care) | - | 1.6 | 3 | mA |
| Power Dissipation | (5V, IOUTFS $=20 \mathrm{~mA}$ ) (Note 6) | - | 165 | - | mW |
|  | $(5 \mathrm{~V}$, IOUTFS $=2 \mathrm{~mA})($ Note 6) | - | 70 | - | mW |
|  | ( 5 V, IOUTFS $=20 \mathrm{~mA}$ ) (Note 9) | - | 150 | - | mW |
|  | (3.3V, IOUTFS $=20 \mathrm{~mA}$ ) ( Note 9) | - | 75 | - | mW |
|  | $(3 \mathrm{~V}$, IOUTFS $=20 \mathrm{~mA})($ Note 6) | - | 85 | - | mW |
|  | (3V, IOUTFS $=20 \mathrm{~mA}$ ) (Note 9) | - | 67 | - | mW |
|  | $(3 \mathrm{~V}$, IOUTFS $=2 \mathrm{~mA})($ Note 6) | - | 27 | - | mW |
| Power Supply Rejection | Single Supply (Note 7) | -0.2 | - | +0.2 | \% FSR/V |

## NOTES:

2. Gain Error measured as the error in the ratio between the full scale output current and the current through RSET (typically $625 \mu \mathrm{~A}$ ). Ideally the ratio should be 31.969 .
3. Parameter guaranteed by design or characterization and not production tested.
4. Spectral measurements made with differential coupled transformer.
5. Measured with the clock at 50MSPS and the output frequency at 1 MHz .
6. Measured with the clock at 100 MSPS and the output frequency at 40 MHz .
7. See 'Definition of Specifications'.
8. It is recommended that the output current be reduced to 12 mA or less to maintain optimum performance for operation below $3 V$. $D V_{D D}$ and $A V_{D D}$ do not have to be equal.
9. Measured with the clock at 60 MSPS and the output frequency at 10 MHz .

## Typical Performance Curves, 5V Power Supply



FIGURE 1. SFDR vs $\mathrm{f}_{\mathrm{OUT}}, \mathrm{CLOCK}=5 \mathrm{MSPS}$


FIGURE 3. SFDR vs $\mathrm{f}_{\mathrm{OUT}}$, CLOCK $=50 \mathrm{MSPS}$


FIGURE 5. SFDR vs $\mathrm{f}_{\mathrm{OUT}}, \mathrm{CLOCK}=125 \mathrm{MSPS}$


FIGURE 2. SFDR vs fout, CLOCK $=25$ MSPS


FIGURE 4. SFDR vs $\mathrm{f}_{\mathrm{OUT}}$, CLOCK $=100 \mathrm{MSPS}$


FIGURE 6. SFDR vs AMPLITUDE, f CLK/fout $=10$

Typical Performance Curves, 5V Power Supply (Continued)


FIGURE 7. SFDR vs AMPLITUDE, f CLK/fout $=5$


FIGURE 9. SFDR vs $\mathrm{I}_{\text {OUt }}, \mathrm{CLOCK}=100 \mathrm{MSPS}$


FIGURE 11. SFDR vs TEMPERATURE, CLOCK = 100MSPS


AMPLITUDE (TOTAL PEAK POWER OF COMBINED TONES) (dBFS)
FIGURE 8. SFDR vs AMPLITUDE OF TWO TONES, f CLK $/ \mathrm{fOUT}=7$


FIGURE 10. DIFFERENTIAL vs SINGLE-ENDED, CLOCK $=100 \mathrm{MSPS}$


FIGURE 12. SINGLE TONE SFDR

## Typical Performance Curves, 5V Power Supply (Continued)



FIGURE 13. TWO TONE, CLOCK = 100MSPS


FIGURE 15. EIGHT-TONE, CLOCK = 100MSPS


FIGURE 17. DIFFERENTIAL NONLINEARITY


FIGURE 14. FOUR-TONE, CLOCK $=100 \mathrm{MSPS}$


FIGURE 16. FOUR-TONE, CLOCK = 50MSPS


FIGURE 18. INTEGRAL NONLINEARITY

## Typical Performance Curves, 5V Power Supply (Continued)



FIGURE 19. POWER vs CLOCK RATE, $\mathrm{f}_{\mathrm{CLK}} / \mathrm{fOUT}=10$, I OUT $=20 \mathrm{~mA}$

## Typical Performance Curves, 3V Power Supply



FIGURE 20. SFDR vs fout, CLOCK = 5MSPS


FIGURE 22. SFDR vs $\mathrm{f}_{\mathrm{OUT}}, \mathrm{CLOCK}=50 \mathrm{MSPS}$


FIGURE 21. SFDR vs fout, CLOCK = 25MSPS


FIGURE 23. SFDR vs $\mathrm{f}_{\mathrm{OUT}}, \mathrm{CLOCK}=100 \mathrm{MSPS}$

Typical Performance Curves, 3V Power Supply (Continued)


FIGURE 24. SFDR vs fout, CLOCK $=125 \mathrm{MSPS}$


FIGURE 26. SFDR vs AMPLITUDE, f CLK/fout $=5$


FIGURE 28. SFDR vs lout, CLOCK $=100 \mathrm{MSPS}$


FIGURE 25. SFDR vs AMPLITUDE, f CLK/fout $=10$


FIGURE 27. SFDR vs AMPLITUDE OF TWO TONES, $\mathrm{f}_{\text {CLK }} / \mathrm{f}$ OUt $=7$


FIGURE 29. DIFFERENTIAL vs SINGLE-ENDED, CLOCK $=100 \mathrm{MSPS}$

## Typical Performance Curves, 3V Power Supply (Continued)



FIGURE 30. SFDR vs TEMPERATURE, CLOCK = 100MSPS


FIGURE 32. TWO-TONE, CLOCK = 100MSPS


FIGURE 34. EIGHT-TONE, CLOCK = 100MSPS


FIGURE 31. SINGLE TONE SFDR


FIGURE 33. FOUR-TONE, CLOCK = 100MSPS


FIGURE 35. FOUR-TONE, CLOCK = 50MSPS

Typical Performance Curves, 3V Power Supply (Continued)


FIGURE 36. DIFFERENTIAL NONLINEARITY


FIGURE 37. INTEGRAL NONLINEARITY


FIGURE 38. POWER vs CLOCK RATE, f CLK $/ \mathrm{f}$ OUT $=10, \mathrm{I}$ OUT $=20 \mathrm{~mA}$

## Timing Diagrams



FIGURE 39. OUTPUT SETTLING TIME DIAGRAM


FIGURE 40. PEAK GLITCH AREA (SINGLET) MEASUREMENT METHOD


FIGURE 41. PROPAGATION DELAY, SETUP TIME, HOLD TIME AND MINIMUM PULSE WIDTH DIAGRAM

## Definition of Specifications

Integral Linearity Error, INL, is the measure of the worst case point that deviates from a best fit straight line of data values along the transfer curve.

Differential Linearity Error, DNL, is the measure of the step size output deviation from code to code. Ideally the step size should be 1 LSB. A DNL specification of 1 LSB or less guarantees monotonicity.

Output Settling Time, is the time required for the output voltage to settle to within a specified error band measured from the beginning of the output transition. In the case of the HI5760, the measurement was done by switching from code 0 to 256, or quarter scale. Termination impedance was $25 \Omega$ due to the parallel resistance of the output $50 \Omega$ and the oscilloscope's $50 \Omega$ input. This also aids the ability to resolve the specified error band without overdriving the oscilloscope.

Singlet Glitch Area, is the switching transient appearing on the output during a code transition. It is measured as the area under the overshoot portion of the curve and is expressed as a Volt-Time specification.

Full Scale Gain Error, is the error from an ideal ratio of 32 between the output current and the full scale adjust current (through R $\mathrm{RET}_{\text {SE }}$ ).

Full Scale Gain Drift, is measured by setting the data inputs to all ones and measuring the output voltage through a known resistance as the temperature is varied from $\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$. It is defined as the maximum deviation from the value measured at room temperature to the value measured at either $\mathrm{T}_{\text {MIN }}$ or $\mathrm{T}_{\text {MAX }}$. The units are ppm of FSR (full scale range) per degree C .

Total Harmonic Distortion, THD, is the ratio of the DAC output fundamental to the RMS sum of the first five harmonics.

Spurious Free Dynamic Range, SFDR, is the amplitude difference from the fundamental to the largest harmonically or non-harmonically related spur within the specified window.

Output Voltage Compliance Range, is the voltage limit imposed on the output. The output impedance load should be chosen such that the voltage developed does not violate the compliance range.
Offset Error, is measured by setting the data inputs to all zeros and measuring the output voltage through a known resistance. Offset error is defined as the maximum deviation of the output current from a value of 0 mA .

Offset Drift, is measured by setting the data inputs to all zeros and measuring the output voltage through a known resistance as the temperature is varied from $\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$. It is defined as the maximum deviation from the value measured at room temperature to the value measured at
either $\mathrm{T}_{\text {MIN }}$ or $\mathrm{T}_{\text {MAX }}$. The units are ppm of FSR (full scale range) per degree C .

Power Supply Rejection, is measured using a single power supply. Its nominal +5 V is varied $\pm 10 \%$ and the change in the DAC full scale output is noted.

Reference Input Multiplying Bandwidth, is defined as the 3 dB bandwidth of the voltage reference input. It is measured by using a sinusoidal waveform as the external reference with the digital inputs set to all 1 s . The frequency is increased until the amplitude of the output waveform is 0.707 of its original value.

Internal Reference Voltage Drift, is defined as the maximum deviation from the value measured at room temperature to the value measured at either Tmin or Tmax. The units are ppm per degree C.

## Detailed Description

The HI5760 is a 10 -bit, current out, CMOS, digital to analog converter. Its maximum update rate is 125MSPS and can be powered by either single or dual power supplies in the recommended range of +3 V to +5 V . It consumes less than 165 mW of power when using a +5 V supply with the data switching at 100MSPS. The architecture is based on a segmented current source arrangement that reduces glitch by reducing the amount of current switching at any one time. The five MSBs are represented by 31 major current sources of equivalent current. The five LSBs are comprised of binary weighted current sources. Consider an input waveform to the converter which is ramped through all the codes from 0 to 1023. The five LSB current sources would begin to count up. When they reached the all high state (decimal value of 31) and needed to count to the next code, they would all turn off and the first major current source would turn on. To continue counting upward, the 5 LSBs would count up another 31 codes, and then the next major current source would turn on and the five LSBs would all turn off. The process of the single, equivalent, major current source turning on and the five LSBs turning off each time the converter reaches another 31 codes greatly reduces the glitch at any one switching point. In previous architectures that contained all binary weighted current sources or a binary weighted resistor ladder, the converter might have a substantially larger amount of current turning on and off at certain, worst-case transition points such as mid-scale and quarter scale transitions. By greatly reducing the amount of current switching at certain 'major' transitions, the overall glitch of the converter is dramatically reduced, improving settling times and transient problems.

## Digital Inputs and Termination

The HI5760 digital inputs are guaranteed to CMOS levels. However, TTL compatibility can be achieved by lowering the supply voltage to 3 V due to the digital threshold of the input buffer being approximately half of the supply voltage. The internal register is updated on the rising edge of the clock. To minimize reflections, proper termination should be implemented. If the lines driving the clock and the digital inputs are $50 \Omega$ lines, then $50 \Omega$ termination resistors should be placed as close to the converter inputs as possible to the digital ground plane (if separate grounds are used).

## Ground Plane(s)

If separate digital and analog ground planes are used, then all of the digital functions of the device and their corresponding components should be over the digital ground plane and terminated to the digital ground plane. The same is true for the analog components and the analog ground plane. The converter will function properly with a single ground plane, as the Evaluation Board is configured in this matter. Refer to the Application Note on the HI5760 Evaluation Board for further discussion of the ground plane(s) upon availability.

## Noise Reduction

To minimize power supply noise, $0.1 \mu \mathrm{~F}$ capacitors should be placed as close as possible to the converter's power supply pins, $A V_{D D}$ and $D V_{D D}$. Also, should the layout be designed using separate digital and analog ground planes, these capacitors should be terminated to the digital ground for $D V_{D D}$ and to the analog ground for $A V_{D D}$. Additional filtering of the power supplies on the board is recommended. See the Application Note on the HI5760 Evaluation Board for more information upon availability.

## Voltage Reference

The internal voltage reference of the device has a nominal value of +1.2 V with a $\pm 60 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$ drift coefficient over the full temperature range of the converter. It is recommended that a $0.1 \mu \mathrm{~F}$ capacitor be placed as close as possible to the REFIO pin, connected to the analog ground. The REFLO pin (16) selects the reference. The internal reference can be selected if pin 16 is tied low (ground). If an external reference is desired, then pin 16 should be tied high (to the analog supply voltage) and the external reference driven into REFIO, pin 17. The full scale output current of the converter is a function of the voltage reference used and the value of $\mathrm{R}_{\text {SET }}$. IOUT should be within the 2 mA to 20 mA range, through operation below 2 mA is possible, with performance degradation.

If the internal reference is used, $\mathrm{V}_{\text {FSADJ }}$ will equal approximately 1.16 V (pin 18). If an external reference is used, $\mathrm{V}_{\text {FSADJ }}$ will equal the external reference. The calculation for IOUT (Full Scale) is:

IOUT $($ Full Scale $)=\left(\mathrm{V}_{\text {FSADJ }} /\right.$ R $\left._{\text {SET }}\right) \times 32$

If the full scale output current is set to 20 mA by using the internal voltage reference (1.16V) and a $1.86 \mathrm{k} \Omega$ RSET resistor, then the input coding to output current will resemble the following:

TABLE 1. INPUT CODING vs OUTPUT CURRENT

| INPUT CODE (D9-DO) | IOUTA (mA) | IOUTB (mA) |
| :---: | :---: | :---: |
| 1111111111 | 20 | 0 |
| 1000000000 | 10 | 10 |
| 0000000000 | 0 | 20 |

## Outputs

IOUTA and IOUTB are complementary current outputs. The sum of the two currents is always equal to the full scale output current minus one LSB. If single ended use is desired, a load resistor can be used to convert the output current to a voltage. It is recommended that the unused output be either grounded or equally terminated. The voltage developed at the output must not violate the output voltage compliance range of -0.3 V to 1.25 V . R LOAD should be chosen so that the desired output voltage is produced in conjunction with the output full scale current, which is described above in the 'Reference' section. If a known line impedance is to be driven, then the output load resistor should be chosen to match this impedance. The output voltage equation is:

$$
\mathrm{V}_{\mathrm{OUT}}=\mathrm{I}_{\mathrm{OUT}} \times \mathrm{R}_{\text {LOAD }}
$$

These outputs can be used in a differential-to-single-ended arrangement to achieve better harmonic rejection. The SFDR measurements in this data sheet were performed with a $1: 1$ transformer on the output of the DAC (see Figure 1). With the center tap grounded, the output swing of pins 21 and 22 will be biased at zero volts. It is important to note here that the negative voltage output compliance range limit is -300 mV , imposing a maximum of $600 \mathrm{mV} \mathrm{V}_{\mathrm{P}-\mathrm{P}}$ amplitude with this configuration. The loading as shown in Figure 1 will result in a 500 mV signal at the output of the transformer if the full scale output current of the DAC is set to 20 mA .


FIGURE 42.
$\mathrm{V}_{\text {OUT }}=2 \times \mathrm{I}_{\text {OUT }} \times \mathrm{R}_{\text {EQ }}$, where $\mathrm{R}_{\text {EQ }}$ is $\sim 12.5 \Omega$

## Pin Descriptions

| PIN NO. | PIN NAME | PIN DESCRIPTION |
| :---: | :---: | :---: |
| 1-10 | D9 (MSB) Through D0 (LSB) | Digital Data Bit 9 (Most Significant Bit) through Digital Data Bit 0, (Least Significant Bit). |
| 11-14 | NC | No Connect. Recommend ground. |
| 15 | SLEEP | Control Pin for Power-Down mode. Sleep Mode is active high; Connect to ground for Normal Mode. Sleep pin has internal $20 \mu \mathrm{~A}$ active pulldown current. |
| 16 | REFLO | Connect to analog ground to enable internal 1.2 V reference or connect to $\mathrm{AV}_{\mathrm{DD}}$ to disable internal reference. |
| 17 | REFIO | Reference voltage input if internal reference is disabled. Reference voltage output if internal reference is enabled. Use $0.1 \mu \mathrm{~F}$ cap to ground when internal reference is enabled. |
| 18 | FSADJ | Full Scale Current Adjust. Use a resistor to ground to adjust full scale output current. Full Scale Output Current $=32 \times V_{\text {FSADJ }} / R_{\text {SET }}$. |
| 19 | COMP1 | For use in reducing bandwidth/noise. Recommended: connect $0.1 \mu \mathrm{~F}$ to $\mathrm{AV}_{\mathrm{DD}}$. |
| 20 | ACOM | Analog Ground. |
| 21 | IOUTB | The complimentary current output of the device. Full scale output current is achieved when all input bits are set to binary 0 . |
| 22 | IOUTA | Current output of the device. Full scale output current is achieved when all input bits are set to binary 1. |
| 23 | NC | Internally connected to ACOM via a resistor. Recommend leave disconnected. Adding a capacitor to ACOM for upward compatibility is valid. Grounding to ACOM is valid. (For upward compatibility to 12-bit and 14 -bit devices, pin 23 needs the ability to have a $0.1 \mu \mathrm{~F}$ capacitor to ACOM .) |
| 24 | $\mathrm{AV}_{\mathrm{DD}}$ | Analog Supply ( +3 V to +5 V ). |
| 25 | NC | No Connect. (For upward compatibility to 12 and 14b devices, pin 25 needs to be grounded to ACOM.) |
| 26 | DCOM | Digital Ground. |
| 27 | DV ${ }_{\text {DD }}$ | Digital Supply ( +3 V to +5 V ). |
| 28 | CLK | Input for clock. Positive edge of clock latches data. |

## Small Outline Plastic Packages (SOIC)



NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15 mm ( 0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25 mm ( 0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. " N " is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width " $B$ ", as measured 0.36 mm ( 0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61 mm ( 0.024 inch)
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

M28.3 (JEDEC MS-013-AE ISSUE C) 28 LEAD WIDE BODY SMALL OUTLINE PLASTIC PACKAGE

| SYMBOL | INCHES |  | MILLIMETERS |  | NOTES |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |  |
| A | 0.0926 | 0.1043 | 2.35 | 2.65 | - |
| A1 | 0.0040 | 0.0118 | 0.10 | 0.30 | - |
| B | 0.013 | 0.0200 | 0.33 | 0.51 | 9 |
| C | 0.0091 | 0.0125 | 0.23 | 0.32 | - |
| D | 0.6969 | 0.7125 | 17.70 | 18.10 | 3 |
| E | 0.2914 | 0.2992 | 7.40 | 7.60 | 4 |
| e | 0.05 BSC |  | 1.27 BSC |  | - |
| H | 0.394 | 0.419 | 10.00 | 10.65 | - |
| h | 0.01 | 0.029 | 0.25 | 0.75 | 5 |
| L | 0.016 | 0.050 | 0.40 | 1.27 | 6 |
| N | 28 |  | 28 |  | 7 |
| $\alpha$ | $0^{0}$ | $8^{0}$ | $0^{0}$ | $8^{0}$ | - |

Thin Shrink Small Outline Plastic Packages (TSSOP)


NOTES:

1. These package dimensions are within allowable dimensions of JEDEC MO-153-AE, Issue E.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension " $D$ " does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15 mm (0.006 inch) per side.
4. Dimension " $E 1$ " does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.15 mm ( 0.006 inch ) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. " $L$ " is the length of terminal for soldering to a substrate.
7. " $N$ " is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. Dimension "b" does not include dambar protrusion. Allowable dambar protrusion shall be 0.08 mm ( 0.003 inch ) total in excess of " $b$ " dimension at maximum material condition. Minimum space between protrusion and adjacent lead is 0.07 mm ( 0.0027 inch ).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact. (Angles in degrees)

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28 LEAD THIN SHRINK SMALL OUTLINE PLASTIC PACKAGE

| SYMBOL | INCHES |  | MILLIMETERS |  | NOTES |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |  |  |  |  |  |  |  |  |  |  |
| A | - | 0.047 | - | 1.20 | - |  |  |  |  |  |  |  |  |  |
| A1 | 0.002 | 0.006 | 0.05 | 0.15 | - |  |  |  |  |  |  |  |  |  |
| A2 | 0.031 | 0.051 | 0.80 | 1.05 | - |  |  |  |  |  |  |  |  |  |
| b | 0.0075 | 0.0118 | 0.19 | 0.30 | 9 |  |  |  |  |  |  |  |  |  |
| c | 0.0035 | 0.0079 | 0.09 | 0.20 | - |  |  |  |  |  |  |  |  |  |
| D | 0.378 | 0.386 | 9.60 | 9.80 | 3 |  |  |  |  |  |  |  |  |  |
| E1 | 0.169 | 0.177 | 4.30 | 4.50 | 4 |  |  |  |  |  |  |  |  |  |
| e | 0.026 | BSC | 0.65 |  | BSC |  |  |  |  |  |  |  |  |  |
| E | 0.246 | 0.256 | 6.25 | 6.50 | - |  |  |  |  |  |  |  |  |  |
| L | 0.0177 | 0.0295 | 0.45 | 0.75 | 6 |  |  |  |  |  |  |  |  |  |
| N | 28 |  |  |  |  |  |  | 28 |  |  |  |  |  | 7 |
| $\alpha$ | $0^{0}$ | $8^{0}$ | $0^{0}$ | $8^{0}$ | - |  |  |  |  |  |  |  |  |  |

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